SCBS665C - JUNE 1996 - REVISED JUNE 2004

- Members of the Texas Instruments
 Widebus™ Family
- Output Ports Have Equivalent 25-Ω Series Resistors, So No External Resistors Are Required
- Typical V_{OLP} (Output Ground Bounce)
 <0.8 V at V_{CC} = 5 V, T_A = 25°C
- High-Impedance State During Power Up and Power Down
- I_{off} and Power-Up 3-State Support Hot Insertion
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17

description/ordering information

These 20-bit transparent D-type latches feature noninverting 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The 'ABT162841 devices can be used as two 10-bit latches or one 20-bit latch. While the latch-enable (1LE or 2LE) input is high, the Q outputs of the corresponding 10-bit latch follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the levels set up at the D inputs.

SN54ABT162841 . . . WD PACKAGE SN74ABT162841 . . . DGG OR DL PACKAGE (TOP VIEW)

| | 1 | | т | | 1 |
|----------|--------|----|--------|----|-------------------|
| 1OE | d | 1 | \cup | 56 | 1LE |
| 1Q1 | q | 2 | | 55 | D1 1D1 |
| 1Q2 | | 3 | | 54 | 1D2 |
| GND | | 4 | | 53 | GND |
| 1Q3 | | 5 | | 52 | 1D3 |
| 1Q4 | | 6 | | 51 | 1D4 |
| V_{CC} | | 7 | | 50 |] v _{cc} |
| 1Q5 | | 8 | | 49 | 1D5 |
| 1Q6 | | 9 | | 48 | 1D6 |
| 1Q7 | | 10 | | 47 | 1D7 |
| GND | | 11 | | 46 | GND |
| 1Q8 | q | 12 | | 45 | 1D8 |
| 1Q9 | | 13 | | 44 | 1D9 |
| 1Q10 | | 14 | | 43 | 1D10 |
| 2Q1 | | 15 | | 42 | 2D1 |
| 2Q2 | | 16 | | 41 | 2D2 |
| 2Q3 | | 17 | | 40 | 2D3 |
| GND | | 18 | | 39 | GND |
| 2Q4 | | 19 | | 38 | 2D4 |
| 2Q5 | | 20 | | 37 | 2D5 |
| 2Q6 | \Box | 21 | | 36 | 2D6 |
| V_{CC} | | 22 | | 35 |] v _{cc} |
| 2Q7 | \Box | 23 | | 34 | 2D7 |
| 2Q8 | | 24 | | 33 | 2D8 |
| GND | Ц | 25 | | 32 | GND |
| 2Q9 | Ц | 26 | | 31 | 2D9 |
| 2Q10 | 4 | 27 | | 30 | 2D10 |
| 2OE | 9 | 28 | | 29 | 2LE |

ORDERING INFORMATION

| TA | PACKAGE [†] | | ORDERABLE PART NUMBER | TOP-SIDE MARKING | |
|----------------|----------------------|---------------|--------------------------|---------------------|--|
| | CCOD DI | Tube | SN74ABT162841DL | ADT400044 | |
| -40°C to 85°C | SSOP – DL | Tape and reel | SN74ABT162841DLR | ABT162841 | |
| | TSSOP - DGG | Tape and reel | SN74ABT162841DGGR | ABT162841 | |
| –55°C to 125°C | CFP – WD | Tube | SNJ54ABT162841WD | SNJ54ABT162841WD | |

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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SCBS665C - JUNE 1996 - REVISED JUNE 2004

description/ordering information (continued)

A buffered output-enable $(1\overline{OE} \text{ or } 2\overline{OE})$ input can be used to place the outputs of the corresponding 10-bit latch in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly.

The outputs, which are designed to sink up to 12 mA, include equivalent 25- Ω series resistors to reduce overshoot and undershoot.

These devices are fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

To ensure the high-impedance state during power up or power down, \overline{OE} shall be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

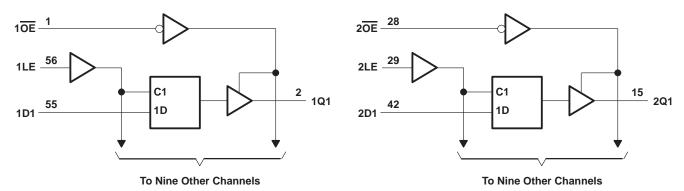
OE does not affect the internal operation of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

FUNCTION TABLE (each 10-bit latch)

| | INPUTS | OUTPUT | |
|----|--------|--------|-------|
| OE | LE | D | Q |
| L | Н | Н | Н |
| L | Н | L | L |
| L | L | Χ | Q_0 |
| Н | X | Χ | Z |



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V _{CC} | –0.5 V to 7 V |
|--|----------------|
| Input voltage range, V _I (see Note 1) | |
| Voltage range applied to any output in the high or power-off state, V _O | |
| Current into any output in the low state, IO | 30 mA |
| Input clamp current, I _{IK} (V _I < 0) | –18 mA |
| Output clamp current, I _{OK} (V _O < 0) | –50 mA |
| Package thermal impedance, θ _{JA} (see Note 2): DGG package | 64°C/W |
| DL package | 56°C/W |
| Storage temperature range, T _{stq} | –65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

| | | | SN54ABT | 162841 | SN74ABT | 162841 | |
|---------------------|------------------------------------|-----------------|---------|--------|---------|--------|------|
| | | | MIN | MAX | MIN | MAX | UNIT |
| Vcc | Supply voltage | | 4.5 | 5.5 | 4.5 | 5.5 | V |
| VIH | High-level input voltage | | 2 | Š | 2 | | V |
| V _{IL} | Low-level input voltage | | | 0.8 | | 8.0 | V |
| VI | Input voltage | | 0 4 | Vcc | 0 | VCC | V |
| IOH | High-level output current | | 1 | -3 | | -12 | mA |
| loL | Low-level output current | | 2 | 8 | | 12 | mA |
| Δt/Δν | Input transition rise or fall rate | Outputs enabled | 30/ | 10 | | 10 | ns/V |
| Δt/ΔV _{CC} | Power-up ramp rate | | 200 | | 200 | · | μs/V |
| TA | Operating free-air temperature | | -55 | 125 | -40 | 85 | °C |

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

SCBS665C - JUNE 1996 - REVISED JUNE 2004

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| | | | ONDITIONS. | Т | A = 25°C | ; | SN54ABT | 162841 | SN74ABT | 162841 | |
|------------------|------------------|--|--|-----|----------|------|---------|--------|---------|--------|------|
| " | ARAMETER | TEST C | ONDITIONS | MIN | TYP† | MAX | MIN | MAX | MIN | MAX | UNIT |
| VIK | | $V_{CC} = 4.5 \text{ V},$ | I _I = -18 mA | | | -1.2 | | -1.2 | | -1.2 | V |
| | | $V_{CC} = 4.5 \text{ V},$ | I _{OH} = -1 mA | 2.5 | | | 2.5 | | 2.5 | | |
| . , | | $V_{CC} = 5 V$, | 3 | | | 3 | | 3 | | V | |
| VOH | | \/ 45\/ | $I_{OH} = -3 \text{ mA}$ | 2.4 | | | 2.4 | | 2.4 | | V |
| | | V _{CC} = 4.5 V | I _{OH} = -12 mA | 2* | | | | | 2 | | |
| ., | | V 45V | I _{OL} = 8 mA | | 0.4 | | | 0.8 | | 0.65 | V |
| VOL | | V _{CC} = 4.5 V | I _{OL} = 12 mA | | 0.8* | | | | | 0.8 | V |
| V _{hys} | | | · | | 100 | | | | | | mV |
| IJ | | $V_{CC} = 0$ to 5.5 $V_I = V_{CC}$ or GN | | | ±1 | | ±1 | | ±1 | μА | |
| lozpu | J | $V_{CC} = 0 \text{ to } 2.1$ $V_{O} = 0.5 \text{ V to } 2$ | | | ±50 | | ±50 | | ±50 | μА | |
| lozpc |) | V _{CC} = 2.1 V to V _O = 0.5 V to 2 | | | ±50 | 2 2 | ±50 | | ±50 | μА | |
| lozh | | V _{CC} = 2.1 V to V _O = 2.7 V, OE | $V_{CC} = 2.1 \text{ V} \text{ to } 5.5 \text{ V},$ $V_{O} = 2.7 \text{ V}, \text{ OE} \ge 2 \text{ V}$ | | | 10 | 2008 | 10 | | 10 | μА |
| lozL | | V _{CC} = 2.1 V to V _O = 0.5 V, OE | 5.5 V, ≥ 2 V | | | -10 | Q | -10 | | -10 | μА |
| loff | | $V_{CC} = 0$, | V_I or $V_O \le 4.5 \text{ V}$ | | | ±100 | | | | ±100 | μΑ |
| ICEX | Outputs high | $V_{CC} = 5.5 \text{ V},$ | V _O = 5.5 V | | | 50 | | 50 | | 50 | μΑ |
| IO [‡] | | $V_{CC} = 5.5 \text{ V},$ | V _O = 2.5 V | -25 | -75 | -100 | -25 | -100 | -25 | -100 | mA |
| | Outputs high | | _ | | | 0.5 | | 0.5 | | 0.5 | |
| ICC | Outputs low | $V_{CC} = 5.5 \text{ V}, \text{ I}_{C}$ $V_{I} = V_{CC} \text{ or G}$ | | | | 89 | | 89 | | 89 | mA |
| | Outputs disabled | 1 - 1 - 100 31 31 | | | | 0.5 | | 0.5 | | 0.5 | |
| ΔlCC§ | | V_{CC} = 5.5 V, One input at 3.4 V, Other inputs at V_{CC} or GND | | | | 1.5 | | 1.5 | | 1.5 | mA |
| C _i | | $V_{I} = 2.5 \text{ V or } 0.$ | 5 V | | 3.5 | | | | | | pF |
| Co | | $V_0 = 2.5 \text{ V or } 0$ |).5 V | | 9 | | | | | | pF |

^{*} On products compliant to MIL-PRF-38535, this parameter does not apply.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

| | | V _{CC} = 5 V, T _A = 25°C | SN54ABT162841 | SN74ABT162841 | UNIT |
|-----------------|--------------------------------|---|---------------|---------------|------|
| | | MIN MAX | MIN MAX | MIN MAX | |
| t _W | Pulse duration, LE high or low | 4 | 4,1,11 | 4 | ns |
| t _{su} | Setup time, data before LE↓ | 0.8 | 0.8 | 0.8 | ns |
| th | Hold time, data after LE↓ | 1.8 | 1,8 | 1.8 | ns |

[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level, rather than VCC or GND.

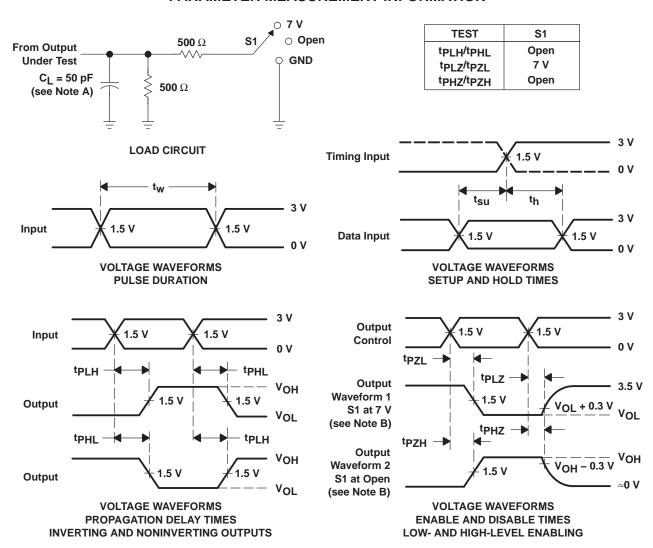
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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM | TO (OUTPUT) | V(| V _{CC} = 5 V, T _A = 25°C | | | SN54ABT162841 | | SN74ABT162841 | |
|------------------|---------|----------------|-----|---|-----|-----|---------------|-----|---------------|----|
| | (INPUT) | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| t _{PLH} | | 0 | 2.1 | 3.5 | 4.5 | 2.1 | 5.7 | 2.1 | 5.2 | |
| t _{PHL} | D | Q | 3 | 4.3 | 5.3 | 3 | 6.2 | 3 | 6 | ns |
| ^t PLH | | 0 | 2.1 | 3.5 | 4.5 | 2.1 | 5.6 | 2.1 | 5.4 | |
| t _{PHL} | LE | Q | 2.8 | 4.1 | 5.1 | 2.8 | 6.1 | 2.8 | 5.8 | ns |
| ^t PZH | ŌĒ | 0 | 2 | 3.6 | 4.7 | 2 | 5.8 | 2 | 5.7 | |
| t _{PZL} | OE | Q | 3 | 4.6 | 5.7 | 83 | 6.7 | 3 | 6.5 | ns |
| ^t PHZ | ŌĒ | Q | 2.6 | 4.3 | 5.7 | 2.6 | 6.6 | 2.6 | 6.5 | 20 |
| tPLZ | OE . | Q | 2.2 | 3.6 | 5.8 | 2.2 | 8.4 | 2.2 | 7.1 | ns |

SCBS665C - JUNE 1996 - REVISED JUNE 2004

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_Q = 50 \ \Omega$, $t_f \leq$ 2.5 ns. $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms







com 18-Sep-2008

PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|-------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| 74ABT162841DGGRE4 | ACTIVE | TSSOP | DGG | 56 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| 74ABT162841DGGRG4 | ACTIVE | TSSOP | DGG | 56 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| 74ABT162841DLRG4 | ACTIVE | SSOP | DL | 56 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ABT162841DGGR | ACTIVE | TSSOP | DGG | 56 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ABT162841DL | ACTIVE | SSOP | DL | 56 | 20 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ABT162841DLG4 | ACTIVE | SSOP | DL | 56 | 20 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| SN74ABT162841DLR | ACTIVE | SSOP | DL | 56 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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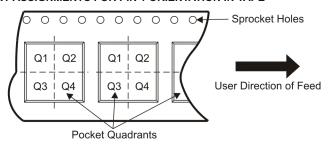
TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

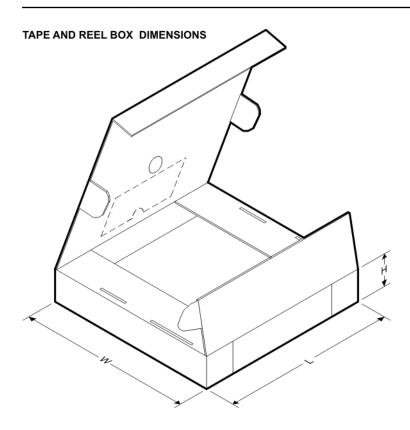
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| SN74ABT162841DGGR | TSSOP | DGG | 56 | 2000 | 330.0 | 24.4 | 8.6 | 15.6 | 1.8 | 12.0 | 24.0 | Q1 |
| SN74ABT162841DLR | SSOP | DL | 56 | 1000 | 330.0 | 32.4 | 11.35 | 18.67 | 3.1 | 16.0 | 32.0 | Q1 |





*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74ABT162841DGGR | TSSOP | DGG | 56 | 2000 | 346.0 | 346.0 | 41.0 |
| SN74ABT162841DLR | SSOP | DL | 56 | 1000 | 346.0 | 346.0 | 49.0 |

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

DL (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

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